

<b>Notice of References Cited</b>			Application No. 09/308,770	Applicant(s) <b>Schwertfeger</b>			
			Examiner <b>Kirsten Crockford</b>	Group Art Unit <b>1762</b>	<b>Page 1 of 2</b>		
<b>U.S. PATENT DOCUMENTS</b>							
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x	N	WO 99/36356	7/1999	PCT	Menon et al.	—	—
x	O	WO 99/36358	7/1999	PCT	Smith et al.	—	—
x	P	WO 99/36479	7/1999	PCT	Menon et al.	—	—
x	Q	WO 99/36480	7/1999	PCT	Menon et al.	—	—
x	R	WO 98/23366	6/1998	PCT	Schwertfeger et al.	—	—
x	S	WO 98/50145	11/1998	PCT	Schmidt	—	—
x	T	WO 98/50144	11/1998	PCT	Schmidt	—	—
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(See Manual of Patent Examining Procedure, Section 707.05(a).)

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